

**Search Notes****Application/Control No.**

10/001,721

**Examiner**

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**Applicant(s)/Patent under Reexamination**

SIMPSON ET AL.

**Art Unit**

2141

**SEARCHED**

Class	Subclass	Date	Examiner
709	203	7/25/2007	DB
709	201	7/25/2007	DB
709	207	7/25/2007	DB
358	1.15	7/25/2007	DB
709	218	7/25/2007	DB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/25/2007	DB
Caonsulted with V. Trans	7/30/2007	DB
Double Patenting search	7/30/2007	D
Eic Fast and Focus	7/30/2007	DB

**INTERFERENCE SEARCHED**

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709	203	7/25/2007	DB
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709	218	7/25/2007	DB